

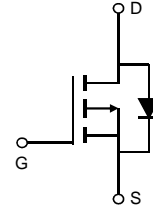
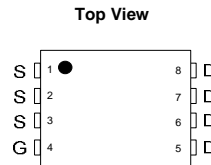
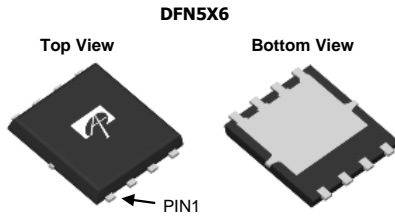
### General Description

The AON6407 combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ . This device is ideal for load switch and battery protection applications.

### Product Summary

|                                    |                 |
|------------------------------------|-----------------|
| $V_{DS}$                           | -30             |
| $I_D$ (at $V_{GS} = -10V$ )        | -85A            |
| $R_{DS(ON)}$ (at $V_{GS} = -10V$ ) | < 4.5m $\Omega$ |
| $R_{DS(ON)}$ (at $V_{GS} = -6V$ )  | < 6.0m $\Omega$ |

100% UIS Tested  
 100%  $R_g$  Tested



### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter                                      | Symbol         | Maximum                 | Units            |
|--|----------------|-------------------------|------------------|
| Drain-Source Voltage                           | $V_{DS}$       | -30                     | V                |
| Gate-Source Voltage                            | $V_{GS}$       | $\pm 25$                | V                |
| Continuous Drain Current <sup>G</sup>          | $I_D$          | $T_C=25^\circ\text{C}$  | -85              |
|  |                | $T_C=100^\circ\text{C}$ | -67              |
| Pulsed Drain Current <sup>C</sup>              | $I_{DM}$       | -200                    | A                |
| Continuous Drain Current                       | $I_{DSM}$      | $T_A=25^\circ\text{C}$  | -32              |
|  |                | $T_A=70^\circ\text{C}$  | -25.5            |
| Avalanche Current <sup>C</sup>                 | $I_{AS}$       | 45                      | A                |
| Avalanche energy $L=0.1\text{mH}$ <sup>C</sup> | $E_{AS}$       | 101                     | mJ               |
| Power Dissipation <sup>B</sup>                 | $P_D$          | $T_C=25^\circ\text{C}$  | 83               |
|  |                | $T_C=100^\circ\text{C}$ | 33               |
| Power Dissipation <sup>A</sup>                 | $P_{DSM}$      | $T_A=25^\circ\text{C}$  | 7.3              |
|  |                | $T_A=70^\circ\text{C}$  | 4.7              |
| Junction and Storage Temperature Range         | $T_J, T_{STG}$ | -55 to 150              | $^\circ\text{C}$ |

### Thermal Characteristics

| Parameter                                  | Symbol          | Typ | Max | Units                     |
|--|-----------------|-----|-----|---------------------------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 14  | 17  | $^\circ\text{C}/\text{W}$ |
| Maximum Junction-to-Ambient <sup>A,D</sup> |                 | 40  | 55  | $^\circ\text{C}/\text{W}$ |
| Maximum Junction-to-Case                   | $R_{\theta JC}$ | 1.1 | 1.5 | $^\circ\text{C}/\text{W}$ |

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter  | Conditions   | Min  | Typ        | Max        | Units |
|-----------------------------|--|--|------|------------|------------|-------|
| <b>STATIC PARAMETERS</b>    |  |  |      |            |            |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage                     | I <sub>D</sub> =-250μA, V <sub>GS</sub> =0V  | -30  |            |            | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current                    | V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                           |      |            | -1<br>-5   | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current                          | V <sub>DS</sub> =0V, V <sub>GS</sub> =±25V   |      |            | ±100       | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                             | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA                                    | -1.6 | -2.1       | -2.6       | V     |
| I <sub>D(ON)</sub>          | On state drain current                             | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-5V  | -200 |            |            | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance                  | V <sub>GS</sub> =-10V, I <sub>D</sub> =-20A<br>T <sub>J</sub> =125°C                         |      | 3.3<br>4.9 | 4.5<br>6.5 | mΩ    |
|                             |  | V <sub>GS</sub> =-6V, I <sub>D</sub> =-20A   |      | 4.4        | 6          |       |
| g <sub>FS</sub>             | Forward Transconductance                           | V <sub>DS</sub> =-5V, I <sub>D</sub> =-20A   |      | 65         |            | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                              | I <sub>S</sub> =-1A, V <sub>GS</sub> =0V   |      | -0.69      | -1         | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current <sup>G</sup> |  |      |            | -85        | A     |
| <b>DYNAMIC PARAMETERS</b>   |  |  |      |            |            |       |
| C <sub>iss</sub>            | Input Capacitance                                  | V <sub>GS</sub> =0V, V <sub>DS</sub> =-15V, f=1MHz   |      | 3505       |            | pF    |
| C <sub>oss</sub>            | Output Capacitance                                 |  |      | 900        |            | pF    |
| C <sub>riss</sub>           | Reverse Transfer Capacitance                       |  |      | 650        |            | pF    |
| R <sub>g</sub>              | Gate resistance                                    | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz   |      | 4.6        | 9.2        | Ω     |
| <b>SWITCHING PARAMETERS</b> |  |  |      |            |            |       |
| Q <sub>g(10V)</sub>         | Total Gate Charge                                  | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V, I <sub>D</sub> =-20A                           |      | 75         | 105        | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                                 |  |      | 13         |            | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                                  |  |      | 23         |            | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                                  | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V,<br>R <sub>L</sub> =0.75Ω, R <sub>GEN</sub> =3Ω |      | 14         |            | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                                  |  |      | 16         |            | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                                 |  |      | 94         |            | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                                 |  |      | 75         |            | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time                   | I <sub>F</sub> =-20A, di/dt=500A/μs  |      | 35         |            | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge                 | I <sub>F</sub> =-20A, di/dt=500A/μs  |      | 75         |            | nC    |

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 150° C may be used if the PCB allows it.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150° C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25° C. Maximum UIS current limited by test equipment.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

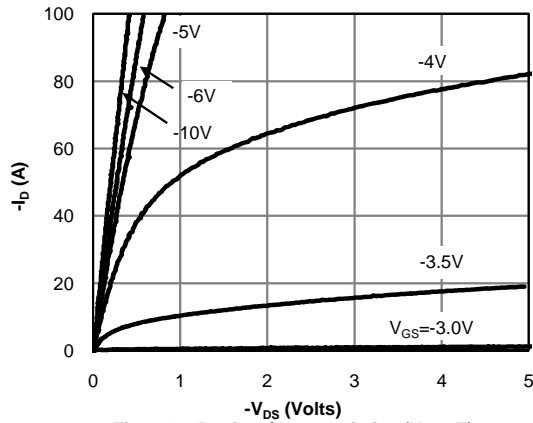
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

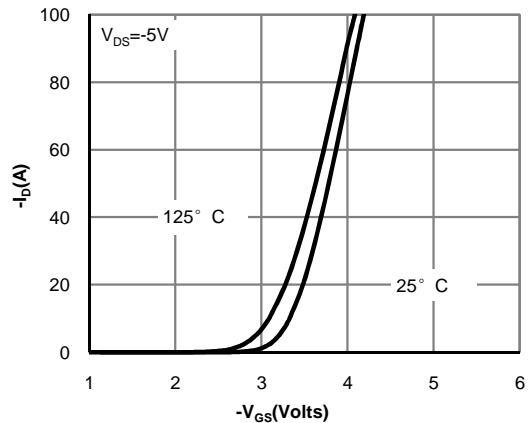
H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.

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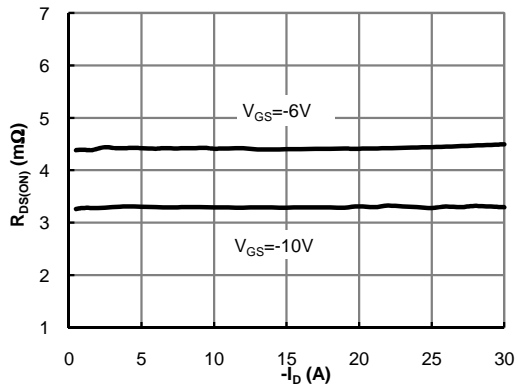
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



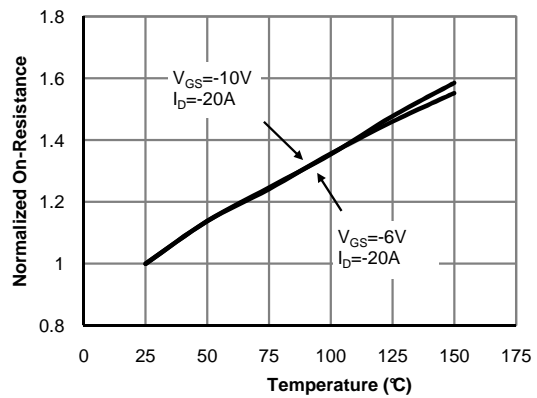
**Figure 1: On-Region Characteristics (Note E)**



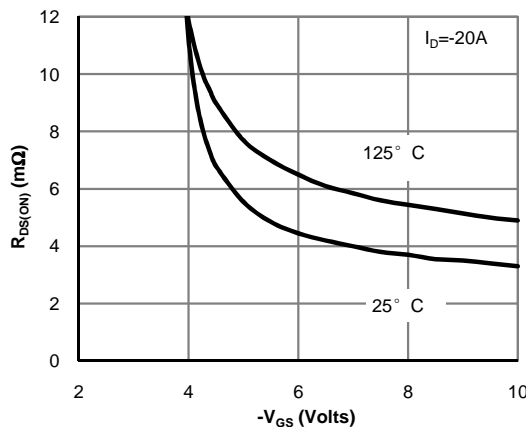
**Figure 2: Transfer Characteristics (Note E)**



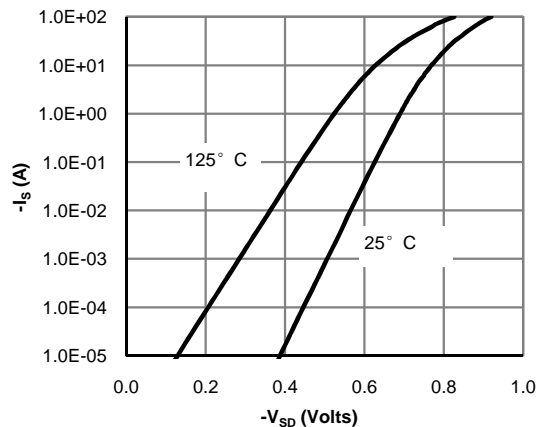
**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**



**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

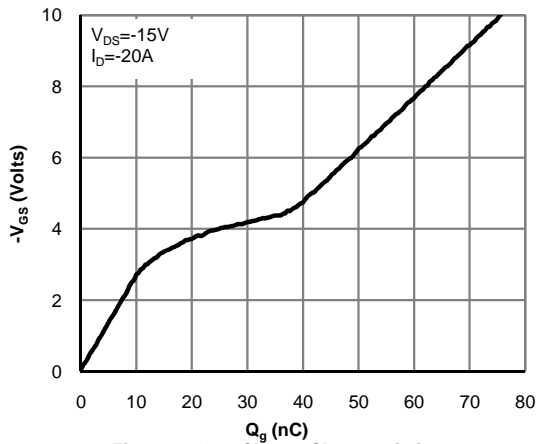


**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

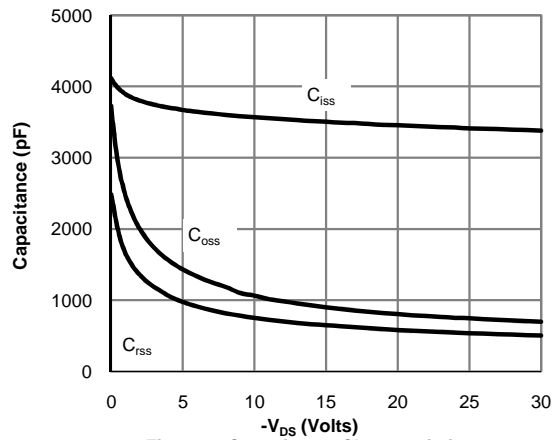


**Figure 6: Body-Diode Characteristics (Note E)**

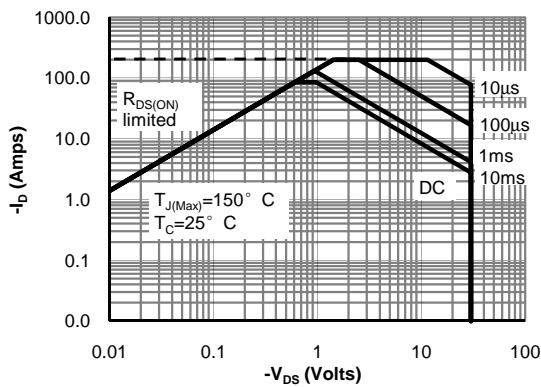
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



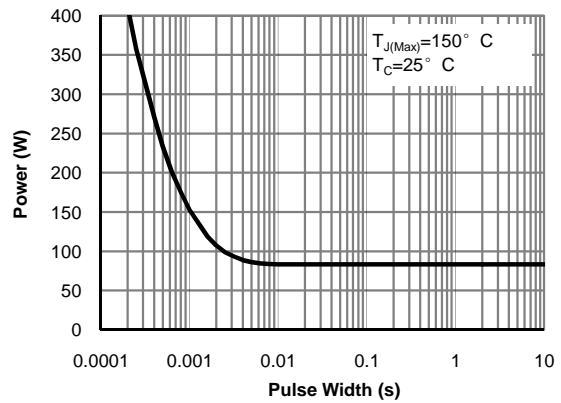
**Figure 7: Gate-Charge Characteristics**



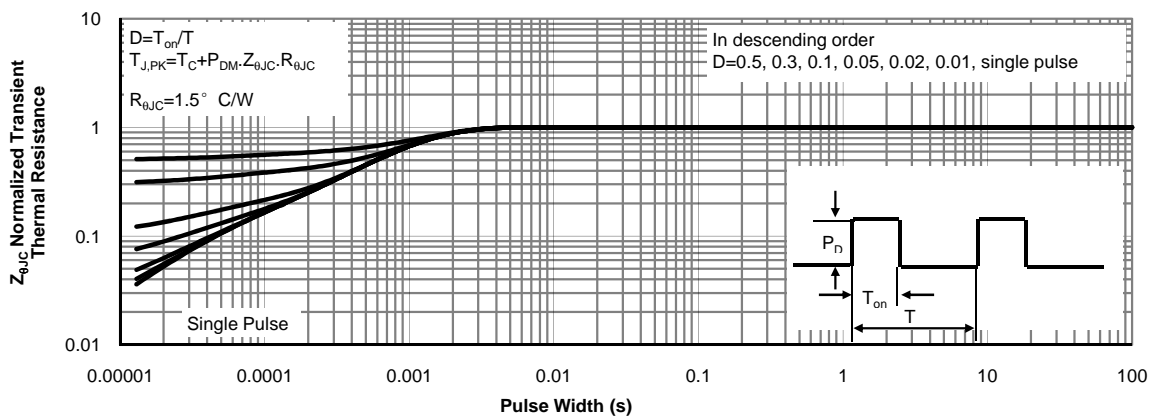
**Figure 8: Capacitance Characteristics**



**Figure 9: Maximum Forward Biased Safe Operating Area (Note F)**

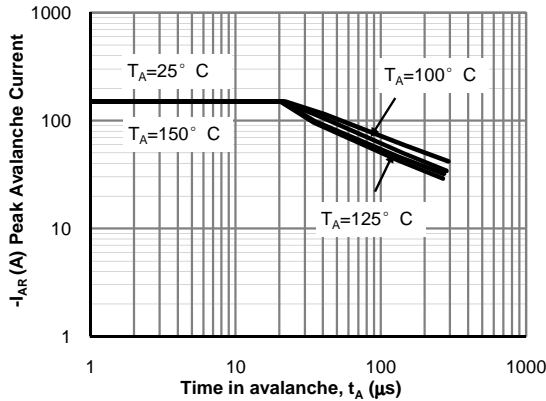


**Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)**

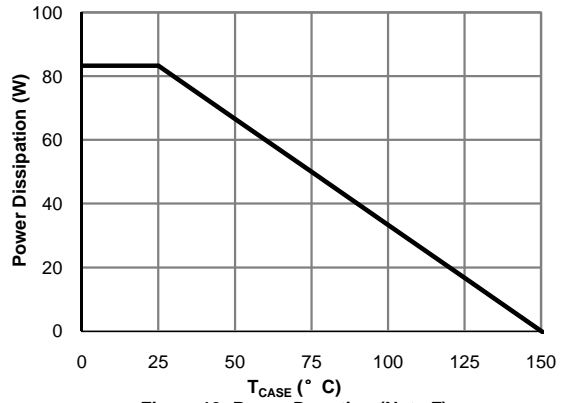


**Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)**

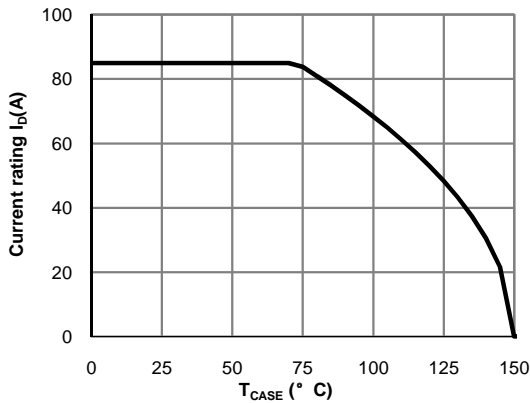
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



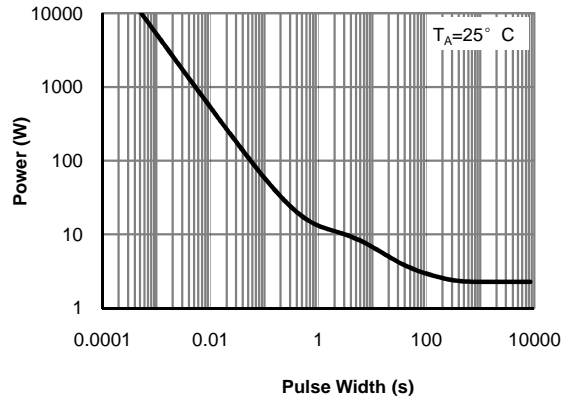
**Figure 12: Single Pulse Avalanche capability (Note C)**



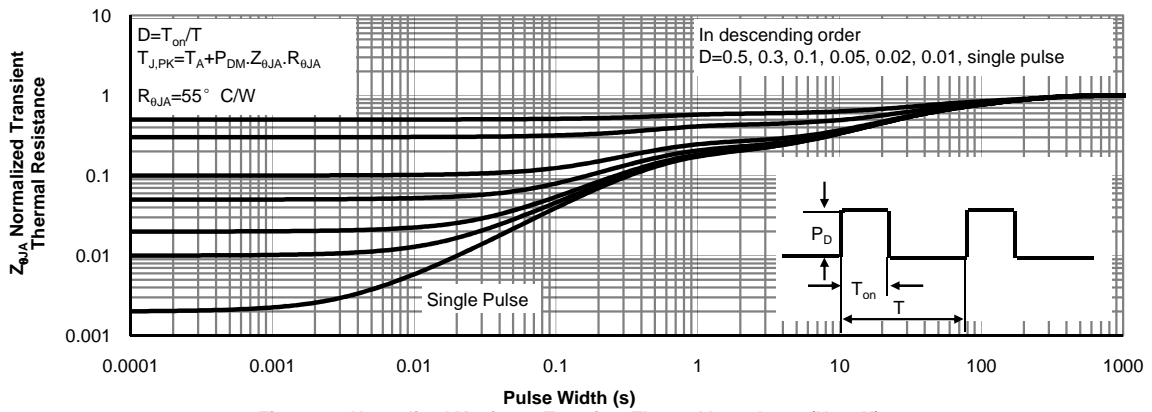
**Figure 13: Power De-rating (Note F)**



**Figure 14: Current De-rating (Note F)**

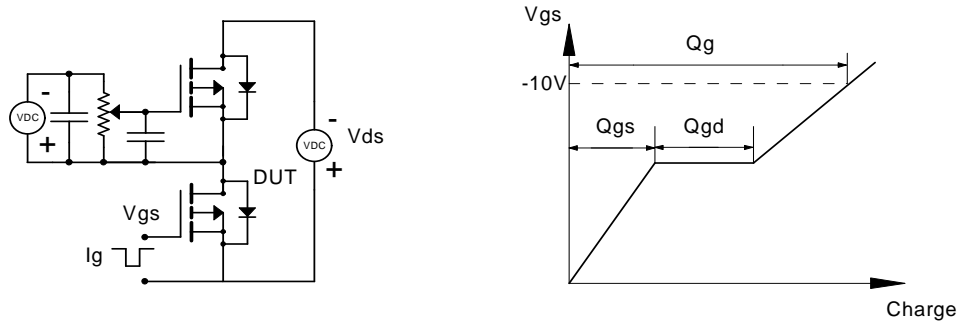


**Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)**

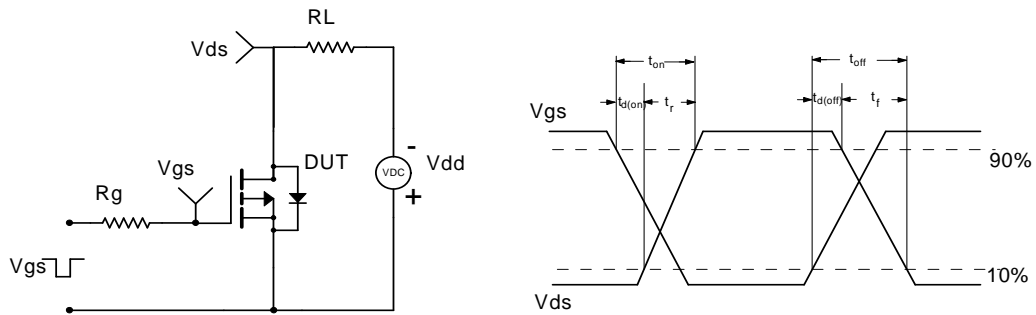


**Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)**

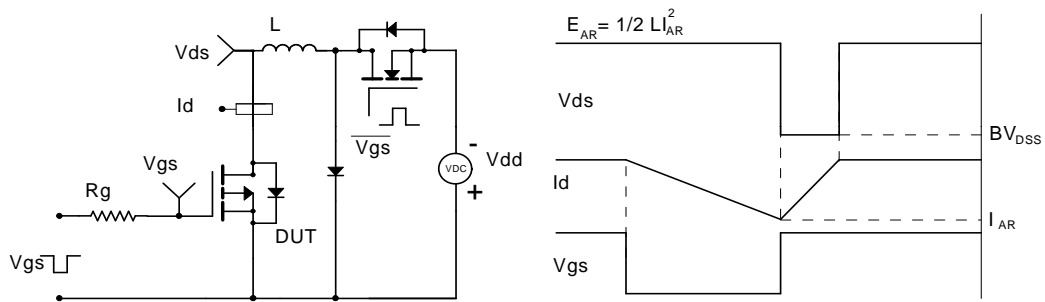
**Gate Charge Test Circuit & Waveform**



**Resistive Switching Test Circuit & Waveforms**



**Unclamped Inductive Switching (UIS) Test Circuit & Waveforms**



**Diode Recovery Test Circuit & Waveforms**

